Philips Components-Signetics

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Status	Product Specification		
Memory Produ	icts		

DESCRIPTION

The 82S130 and 82S131 are field programmable, which means that custom patterns are immediately available by following the Signetics Generic I fusing procedure. The 82S130 and 82S131 devices are supplied with all outputs at logical Low. Outputs are programmed to a logic High level at any specified address by fusing the Ni-Cr link matrix.

These devices include on-chip decoding and 1 Chip Enable input for ease of memory expansion. They feature either Open Collector or 3-State outputs for optimization of word expansion in bused organizations.

Ordering information can be found on the following page.

The 82S130 and 82S131 devices are also processed to military requirements for operation over the military temperature range. For specifications and ordering information, consult the Signetics Military Data Handbook.

FEATURES

82S130 82S131

Address access time: 50ns max

2K-bit TTL bipolar PROM

- Power dissipation: 0.3mW/bit typ
- Input loading: –100µA max
- On-chip address decoding
- One Chip Enable input
- Output options:
 - N82S130: Open Collector
 - N82S131: 3-State
- No separate fusing pins
- Unprogrammed outputs are Low level
- Fully TTL compatible

APPLICATIONS

- Prototyping/volume production
- Sequential controllers
- Microprogramming
- Hardwired algorithms
- Control store
- Random logic
- Code conversion

PIN CONFIGURATIONS





2K-bit TTL bipolar PROM (512 × 4)

82S130 / 82S131

ORDERING INFORMATION

DESCRIPTION	ORDER CODE		
16-Pin Plastic Dual-In-Line 300mil-wide	N82S130 N, N82S131 N		
20-Pin Plastic Leaded Chip Carrier 350mil-square	N82S130 A, N82S131 A		

ABSOLUTE MAXIMUM RATINGS

SYMBOL	PARAMETER	RATING	UNIT
Vcc	Supply voltage	+7.0	V _{DC}
VIN	Input voltage	+5.5	V _{DC}
Voн	Output voltage High (82S130)	+5.5	VDC
Vo	Output voltage Off-State (82S131)	+5.5	V _{DC}
Tamb	Operating temperature range	0 to +75	°C
T _{stg}	Storage temperature range	-65 to +150	°C

DC ELECTRICAL CHARACTERISTICS $0^{\circ}C \leq T_{amb} \leq +75^{\circ}C, 4.75V \leq V_{CC} \leq 5.25V$

			LIMITS				
YMBOL PARAMETER		TEST CONDITIONS ^{1,2}	Min	Typ ³	Мах	UNIT	
Input volt	age						
VIL	Low				0.8	v	
ViH	High		2.0			V	
VIC	Clamp	l _{IN} = -12mA			-1.2	v	
Output vo	Itage						
		CE = Low					
VOL	Low	I _{OUT} = 16mA			0.45	v	
V _{OH}	High (82S131)	1 _{OUT} = -2.0mA	2.4			٧	
Input curr	rent						
I	Low	V _{IN} = 0.45V			-100	μA	
l _{IH}	High	$V_{IN} = 5.5V$			40	μA	
Output cu	irrent						
IOLK	Leakage (82S130)	CE = High, V _{OUT} = 5.5V	ligh, Vour = 5.5V		40	μA	
Inz	Hi-Z state (82S131)	CE = High, V _{OUT} = 5.5V			40	μΑ	
-		$\overline{CE} = High, V_{OUT} = 0.5V$			-40	μΑ	
los	Short circuit (82S131) ⁴	CE = Low, V _{OUT} = 0V, High stored -15 -70		-70	mA		
Supply cu	urrent ⁵						
lcc		V _{CC} = 5.25V			140	mA	
Capacitar	nce						
		CE = High, V _{CC} = 5.0V					
C _{IN}	Input	$V_{IN} = 2.0V$		5		pF	
COUT	Output	$V_{OUT} = 2.0V$		8		pF	

NOTES:

1. Positive current is defined as into the terminal referenced.

2. All voltages with respect to network ground. 3. Typical values are at $V_{CC} = 5V$, $T_{amb} = +25^{\circ}C$. 4. Duration of short circuit should not exceed 1 second. 5. Measured with all inputs grounded and all outputs open.

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2K-bit TTL bipolar PROM (512 × 4)

82S130 / 82S131

AC ELECTRICAL CHARACTERISTICS

 $R_1 = 270\Omega$, $R_2 = 600\Omega$, $C_L = 30 pF_0^{\circ}C \le T_{amb} \le +75^{\circ}C$, $4.75V \le V_{CC} \le 5.25V$

SYMBOL	PARAMETER	то	FROM	LIMITS			
				Min	Typ1	Max	UNIT
Access time	2				_		
t _{AA}		Output	Address			50	ns
t _{CE}		Output	Chip Enable			30	ns
Disable time	3			•	L		
1 _{CD}		Output	Chip Disable		1	30	ns

TES:

1. Typical values are at V_{CC} = 5V, T_{amb} = +25°C. 2. Tested at an address cycle time of 1 μ s. 3. Measured at a delta of 0.5V from Logic Level with R₁ = 750 Ω , R₂ = 750 Ω , C_L = 5pF.

TEST LOAD CIRCUIT



VOLTAGE WAVEFORMS



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